

## OptiMOS<sup>®</sup> -T Power-Transistor



### Features

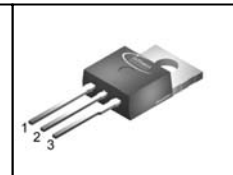
- N-channel - Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- 100% Avalanche tested

### Product Summary

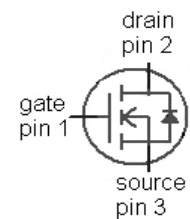
|                                |     |    |
|--------------------------------|-----|----|
| $V_{DS}$                       | 100 | V  |
| $R_{DS(on),max}$ (SMD version) | 4.8 | mΩ |
| $I_D$                          | 100 | A  |

**PG-TO263-3-2**

**PG-TO262-3-1**

**PG-TO220-3-1**


| Type           | Package      | Marking |
|----------------|--------------|---------|
| IPB100N10S3-05 | PG-TO263-3-2 | 3PN1005 |
| IPI100N10S3-05 | PG-TO262-3-1 | 3PN1005 |
| IPP100N10S3-05 | PG-TO220-3-1 | 3PN1005 |



**Maximum ratings**, at  $T_j=25\text{ °C}$ , unless otherwise specified

| Parameter                                    | Symbol            | Conditions                                         | Value        | Unit |
|----------------------------------------------|-------------------|----------------------------------------------------|--------------|------|
| Continuous drain current <sup>1)</sup>       | $I_D$             | $T_C=25\text{ °C}$ , $V_{GS}=10\text{ V}$          | 100          | A    |
|                                              |                   | $T_C=100\text{ °C}$ ,<br>$V_{GS}=10\text{ V}^{2)}$ | 100          |      |
| Pulsed drain current <sup>2)</sup>           | $I_{D,pulse}$     | $T_C=25\text{ °C}$                                 | 400          |      |
| Avalanche energy, single pulse <sup>2)</sup> | $E_{AS}$          | $I_D=50\text{ A}$                                  | 1445         | mJ   |
| Avalanche current, single pulse              | $I_{AS}$          |                                                    | 100          | A    |
| Gate source voltage                          | $V_{GS}$          |                                                    | ±20          | V    |
| Power dissipation                            | $P_{tot}$         | $T_C=25\text{ °C}$                                 | 300          | W    |
| Operating and storage temperature            | $T_j$ , $T_{stg}$ |                                                    | -55 ... +175 | °C   |
| IEC climatic category; DIN IEC 68-1          |                   |                                                    | 55/175/56    |      |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Thermal characteristics<sup>2)</sup>**

|                                                |            |                                              |   |   |     |     |
|------------------------------------------------|------------|----------------------------------------------|---|---|-----|-----|
| Thermal resistance, junction - case            | $R_{thJC}$ |                                              | - | - | 0.5 | K/W |
| Thermal resistance, junction - ambient, leaded | $R_{thJA}$ |                                              | - | - | 62  |     |
| SMD version, device on PCB                     | $R_{thJA}$ | minimal footprint                            | - | - | 62  |     |
|                                                |            | 6 cm <sup>2</sup> cooling area <sup>3)</sup> | - | - | 40  |     |

**Electrical characteristics, at  $T_j=25\text{ °C}$ , unless otherwise specified**
**Static characteristics**

|                                  |               |                                                                 |     |      |     |               |
|----------------------------------|---------------|-----------------------------------------------------------------|-----|------|-----|---------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}, I_D=1\text{ mA}$                            | 100 | -    | -   | V             |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS}=V_{GS}, I_D=240\mu\text{A}$                             | 2.0 | 3.0  | 4.0 |               |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS}=80\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ °C}$       | -   | 0.01 | 1   | $\mu\text{A}$ |
|                                  |               | $V_{DS}=80\text{ V}, V_{GS}=0\text{ V}, T_j=125\text{ °C}^{2)}$ | -   | 1    | 100 |               |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=20\text{ V}, V_{DS}=0\text{ V}$                         | -   | -    | 100 | nA            |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=10\text{ V}, I_D=100\text{ A}$                          | -   | 4.3  | 5.1 | m $\Omega$    |
|                                  |               | $V_{GS}=10\text{ V}, I_D=100\text{ A},$<br>SMD version          | -   | 4.0  | 4.8 |               |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Dynamic characteristics<sup>2)</sup>**

|                              |              |                                                       |   |      |       |    |
|------------------------------|--------------|-------------------------------------------------------|---|------|-------|----|
| Input capacitance            | $C_{iss}$    | $V_{GS}=0V, V_{DS}=25V,$<br>$f=1MHz$                  | - | 8900 | 11570 | pF |
| Output capacitance           | $C_{oss}$    |                                                       | - | 2520 | 3276  |    |
| Reverse transfer capacitance | $C_{rss}$    |                                                       | - | 220  | 330   |    |
| Turn-on delay time           | $t_{d(on)}$  | $V_{DD}=20V, V_{GS}=10V,$<br>$I_D=80A, R_G=3.5\Omega$ | - | 34   | -     | ns |
| Rise time                    | $t_r$        |                                                       | - | 17   | -     |    |
| Turn-off delay time          | $t_{d(off)}$ |                                                       | - | 60   | -     |    |
| Fall time                    | $t_f$        |                                                       | - | 20   | -     |    |

**Gate Charge Characteristics<sup>2)</sup>**

|                       |               |                                                       |   |     |     |    |
|-----------------------|---------------|-------------------------------------------------------|---|-----|-----|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=80V, I_D=100A,$<br>$V_{GS}=0 \text{ to } 10V$ | - | 47  | 61  | nC |
| Gate to drain charge  | $Q_{gd}$      |                                                       | - | 34  | 51  |    |
| Gate charge total     | $Q_g$         |                                                       | - | 135 | 176 |    |
| Gate plateau voltage  | $V_{plateau}$ |                                                       | - | 5.5 | -   | V  |

**Reverse Diode**

|                                                |               |                                             |     |     |     |    |
|------------------------------------------------|---------------|---------------------------------------------|-----|-----|-----|----|
| Diode continuous forward current <sup>2)</sup> | $I_S$         | $T_C=25^\circ C$                            | -   | -   | 100 | A  |
| Diode pulse current <sup>2)</sup>              | $I_{S,pulse}$ |                                             | -   | -   | 400 |    |
| Diode forward voltage                          | $V_{SD}$      | $V_{GS}=0V, I_F=80A,$<br>$T_j=25^\circ C$   | 0.6 | 1   | 1.2 | V  |
| Reverse recovery time <sup>2)</sup>            | $t_{rr}$      | $V_R=50V, I_F=I_S,$<br>$di_F/dt=100A/\mu s$ | -   | 108 | -   | ns |
| Reverse recovery charge <sup>2)</sup>          | $Q_{rr}$      |                                             | -   | 380 | -   | nC |

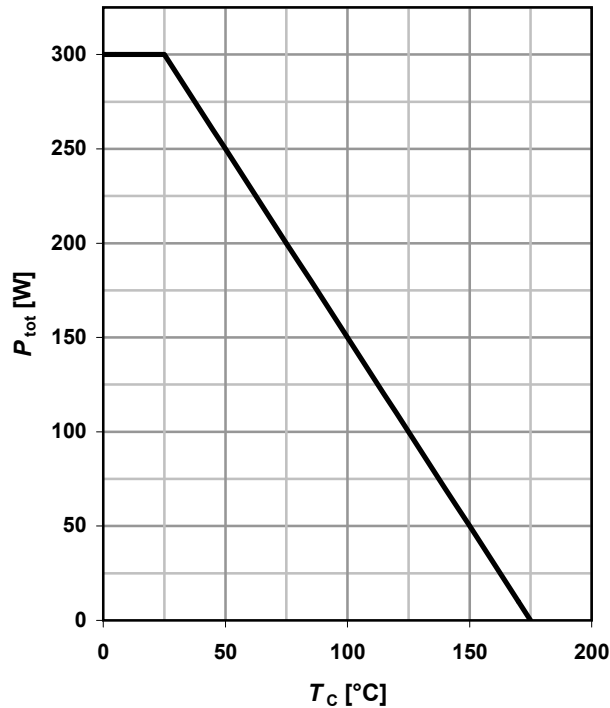
<sup>1)</sup> Current is limited by bondwire; with an  $R_{thJC} = 0.5K/W$  the chip is able to carry 165A at 25°C. For detailed information see Application Note ANPS071E

<sup>2)</sup> Defined by design. Not subject to production test.

<sup>3)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

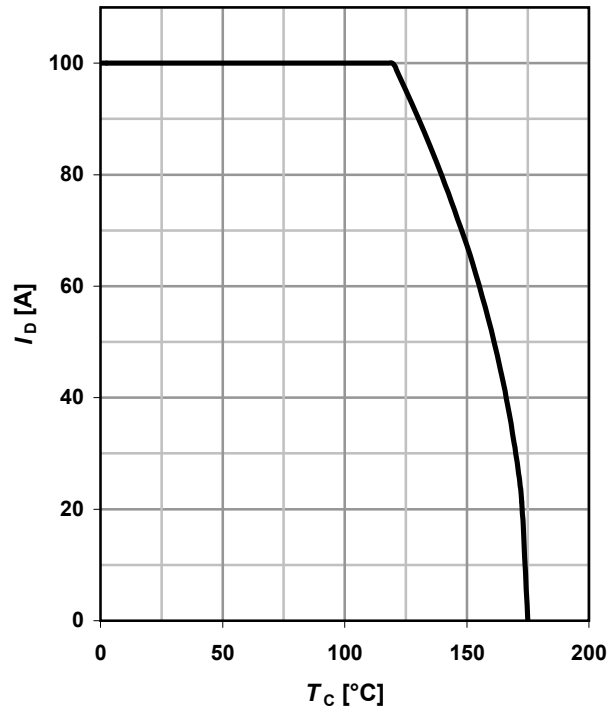
### 1 Power dissipation

$$P_{\text{tot}} = f(T_C); V_{\text{GS}} \geq 6 \text{ V}$$



### 2 Drain current

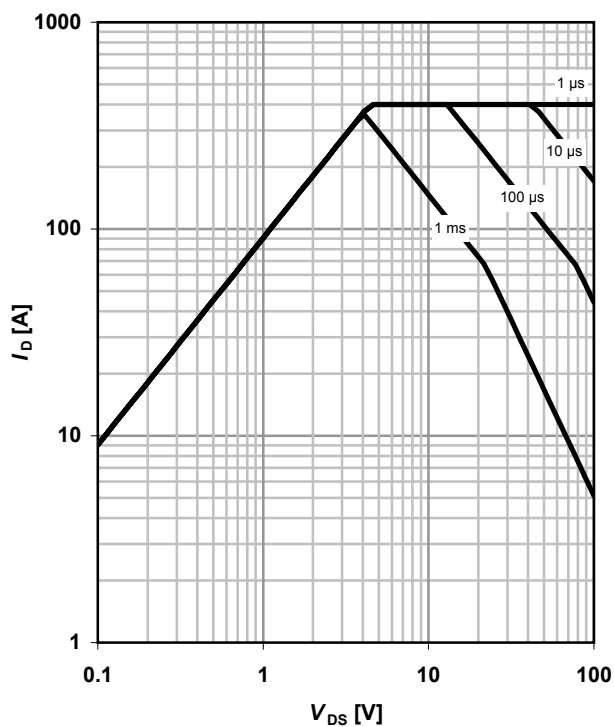
$$I_D = f(T_C); V_{\text{GS}} \geq 6 \text{ V}; \text{SMD}$$



### 3 Safe operating area

$$I_D = f(V_{\text{DS}}); T_C = 25 \text{ °C}; D = 0; \text{SMD}$$

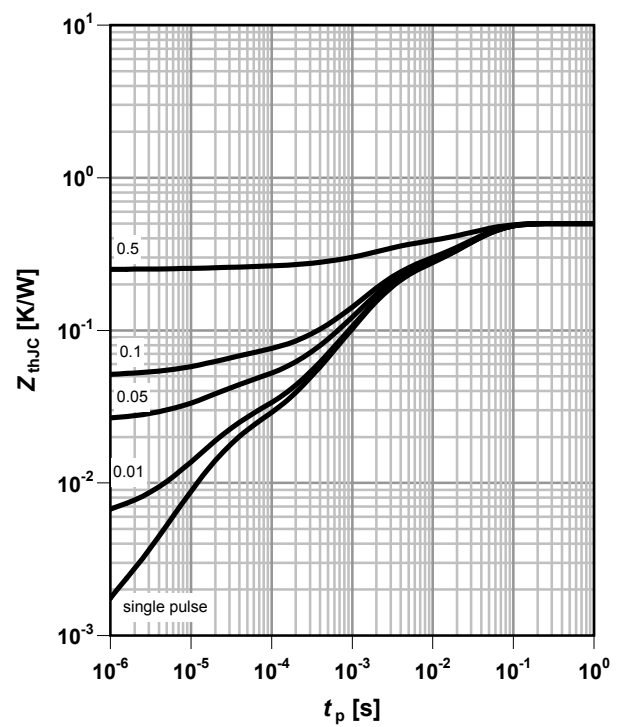
parameter:  $t_p$



### 4 Max. transient thermal impedance

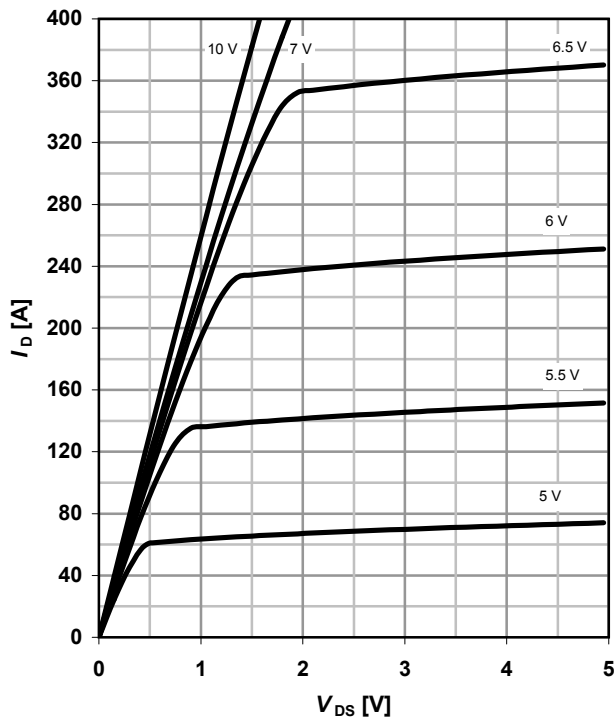
$$Z_{\text{thJC}} = f(t_p)$$

parameter:  $D = t_p/T$



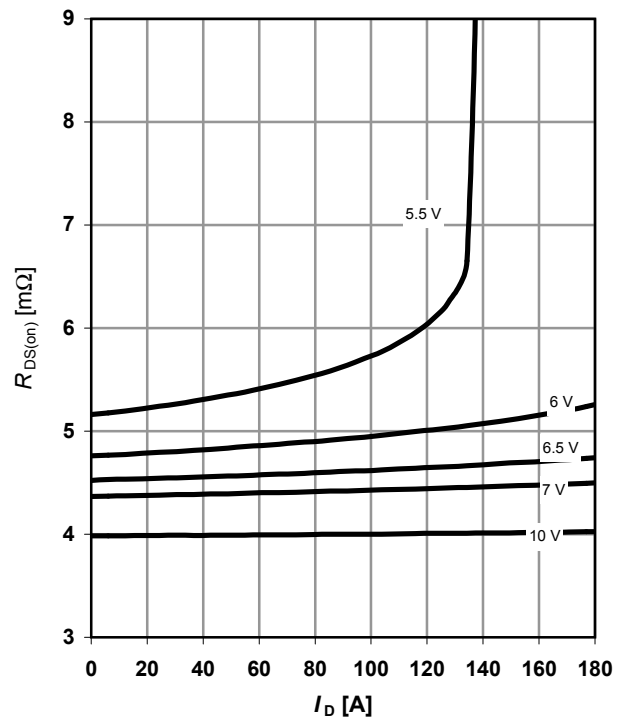
### 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25\text{ °C}; \text{SMD}$ 

parameter:  $V_{GS}$ 


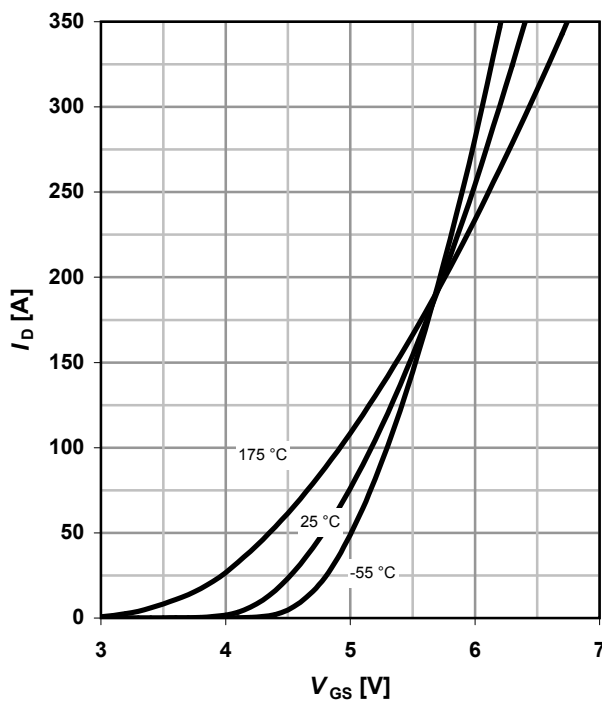
### 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25\text{ °C}; \text{SMD}$ 

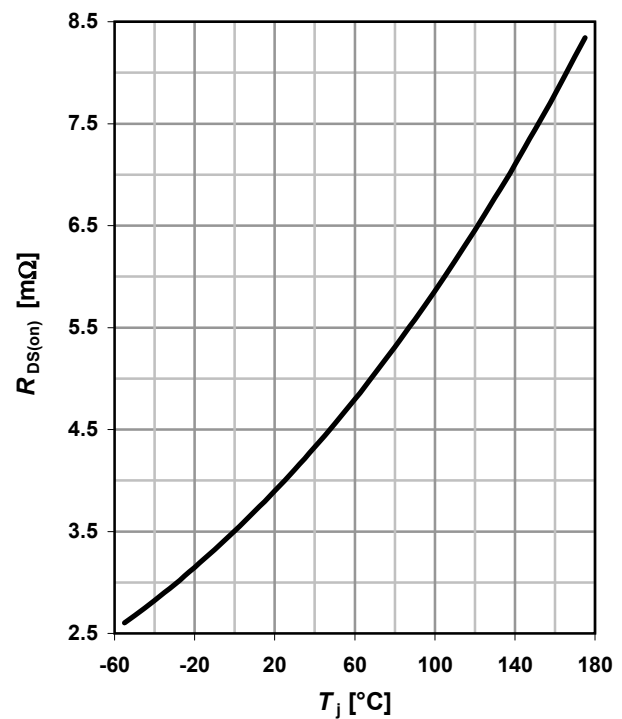
parameter:  $V_{GS}$ 


### 7 Typ. transfer characteristics

 $I_D = f(V_{GS}); V_{DS} = 6\text{ V}$ 

parameter:  $T_j$ 


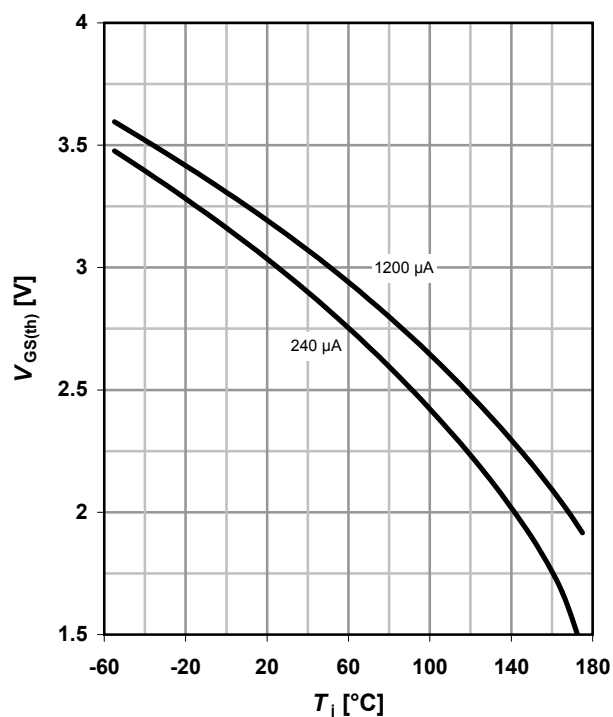
### 8 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j); I_D = 100\text{ A}; V_{GS} = 10\text{ V}; \text{SMD}$ 


## 9 Typ. gate threshold voltage

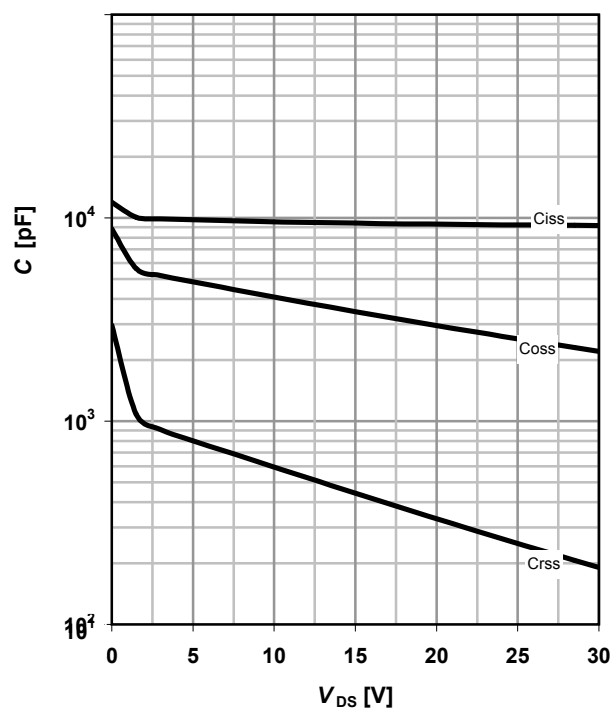
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$

parameter:  $I_D$



## 10 Typ. capacitances

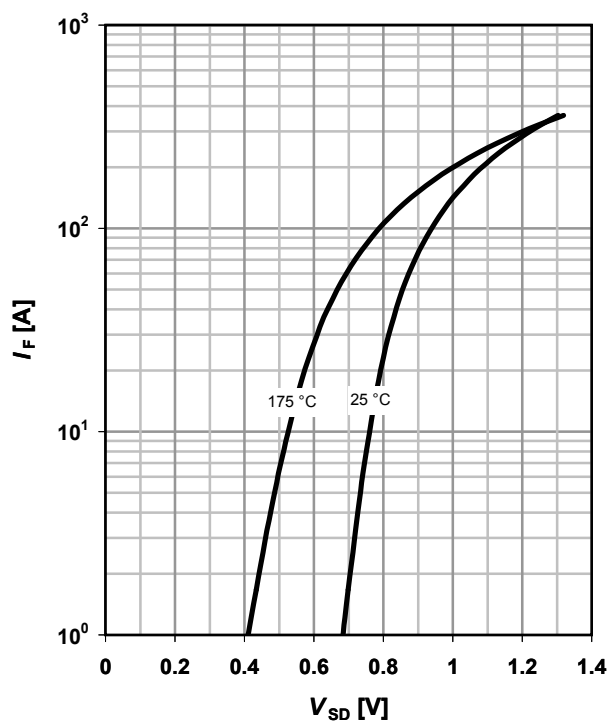
$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$



## 11 Typical forward diode characteristics

$$I_F = f(V_{SD})$$

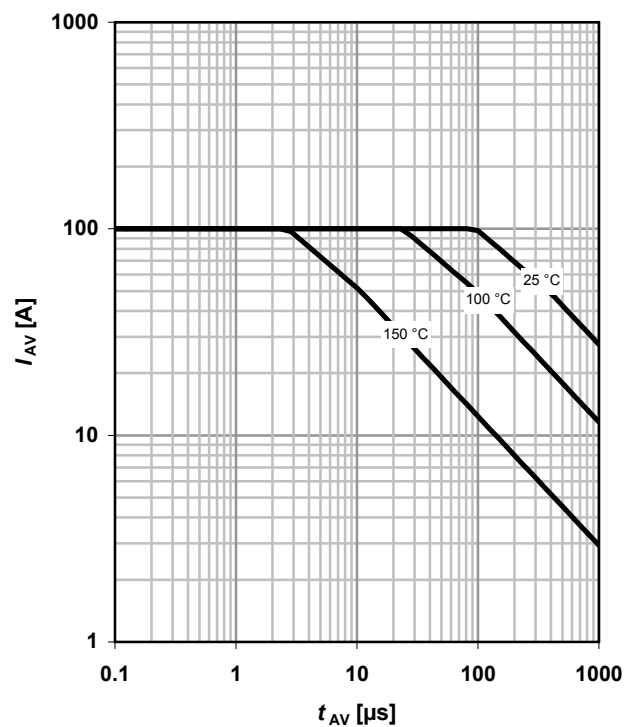
parameter:  $T_j$



## 12 Typ. avalanche characteristics

$$I_{AS} = f(t_{AV})$$

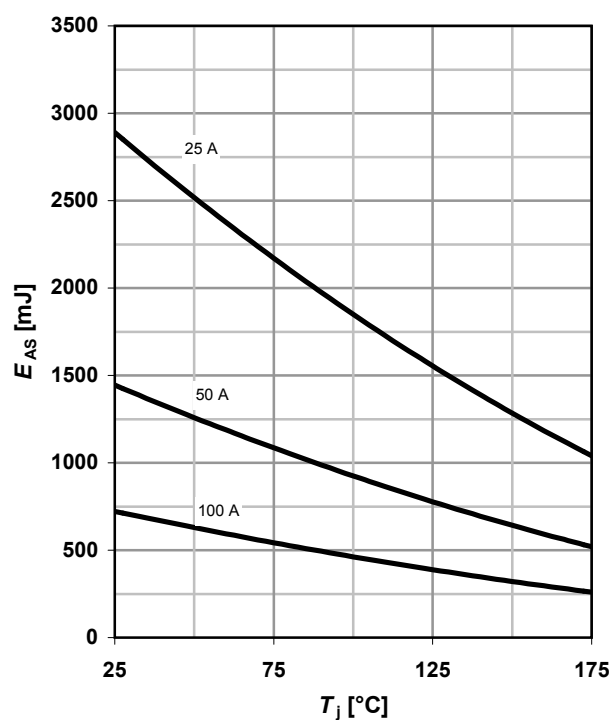
parameter:  $T_{j(start)}$



### 13 Typical avalanche energy

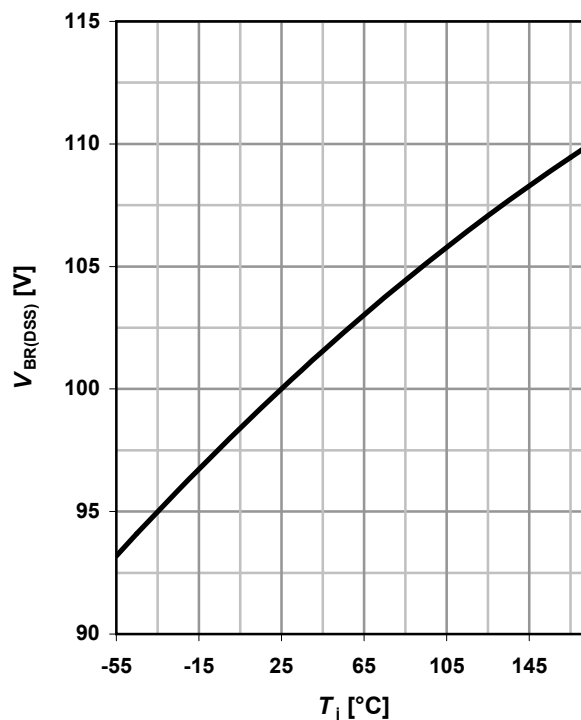
$$E_{AS} = f(T_j)$$

parameter:  $I_D$



### 14 Typ. drain-source breakdown voltage

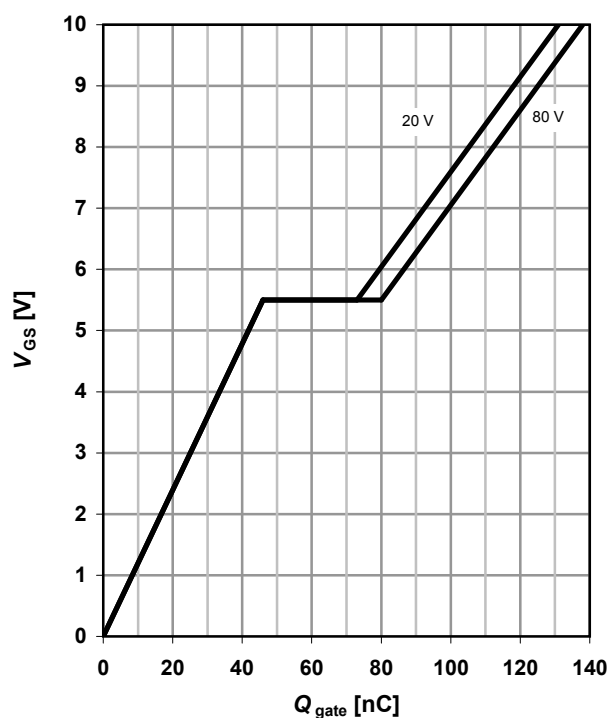
$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$



### 15 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 100 \text{ A pulsed}$$

parameter:  $V_{DD}$



### 16 Gate charge waveforms



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## Revision History

| Version | Date | Changes |
|---------|------|---------|
|         |      |         |
|         |      |         |
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Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

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- Поставка более 17-ти миллионов наименований электронных компонентов;
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- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
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- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

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- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



#### Как с нами связаться

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